

Final Product/Process Change Notification

Document #:FPCN23774Z Issue Date:29 Jan 2021

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Title of Change:	Gresham device release as drop-in replacement for 9731x family	
Proposed Changed Material First Ship Date:	29 Jan 2022 or earlier if approved by customer	
Current Material Last Order Date:	28 Jun 2021 Orders received after the Current Material Last Order Date expiration are to be considered as orders for new changed material as described in this PCN. Orders for current (unchanged) material after this date will be per mutual agreement and current material inventory availability.	
Current Material Last Delivery Date:	28 Jan 2022 The Current Material Last Delivery Date may be subject to change based on build and depletion of the current (unchanged) material inventory	
Product Category:	Active components – Integrated circuits	
Contact information:	Contact your local ON Semiconductor Sales Office or Kevin.Mathews@onsemi.com	
PCN Samples Contact:	Contact your local ON Semiconductor Sales Office to place sample order or <pcn.samples@onsemi.com>. Sample requests are to be submitted no later than 45 days after publication of this change notification. Samples delivery timing will be subject to request date, sample quantity and special customer packing/label requirements.</pcn.samples@onsemi.com>	
Sample Availability Date:	samples available now	
PPAP Availability Date:	11 Feb 2021	
Additional Reliability Data:	Contact your local ON Semiconductor Sales Office or Peter.Turlo@onsemi.com	
Type of Notification:	This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 12 months prior to implementation of the change or earlier upon customer approval. ON Semiconductor will consider this proposed change and it's conditions acceptable, unless an inquiry is made in writing within 45 days of delivery of this notice. To do so, contact PCN.Support@onsemi.com.	
Change Category		
Category	Type of Change	
Design	Design Change in Routing	
Packing/Shipping	Change of labelling	
Process - Wafer Production	Move of all or part of wafer fab to a different location/site/subcontractor, New wafer diameter	
Process - Assembly	Change of mold compound, Change of product marking	

Description and Purpose:

The 6" wafer Fab2 Belgium variants of the 9731x family will stop production at Fab sell-off.

To prevent supply discontinuity, the released 8" wafer Gresham variants are to be used as qualified drop-in replacements.

Summary of Part Differences:

- A design fix for floating node-issues is included on the Gresham variants.
- An overall improved package BOM is used on the Gresham variants (for improved solderability/delamination performance).
- Gresham production uses 8-inch (200mm) wafers for this family.
- For traceability, the Gresham variants use an updated package marking.

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	Before Change Description	After Change Description
	NCV97310MW33R2G	NCV97310MW33AR2G
OPN	NCV97311MW33R2G	NCV97311MW33AR2G
	NCV97311MW50R2G	NCV97311MW50AR2G
Wafer Fab location	Fab2, Oudenaarde, Belgium	Gresham, Oregon, USA
Wafer Diameter	150mm	200mm
LeadFrame	SFS - Wettable Flanks	SLP - Step Cut - Wettable Flanks
Mold Compound	G770 HCD	G700 LTD

	From	То
Product marking change	Line 1: NCV9731X	Line 1: NCV9731X
	Line 2: XX	Line 2: XXA

Anticipated impact on fit, form, function, reliability, product safety or manufacturability: The device has been qualified and validated based on the same Product Specification. The device has successfully passed the qualification tests. Potential impacts can be identified, but due to testing performed by ON Semiconductor in relation to the PCN, associated risks are verified and excluded. No anticipated impacts.	Reason / Motivation for Change:	Capacity improvement
	function, reliability, product	successfully passed the qualification tests. Potential impacts can be identified, but due to testing performed by ON Semiconductor in relation to the PCN, associated risks are verified and excluded.

Sites Affected:

ON Semiconductor Sites	External Foundry/Subcon Sites
ON Semiconductor Gresham Oregon	UTAC, Thailand

Marking of Parts/	Traceability of
Change:	

New OPN with new package marking

Reliability Data Summary:

QV DEVICE NAME : NCV97311MW50AR2G

RMS: E53608, O51050, O50019, O43143, E43144, O48263, O48214, O46500, E48456, O38963

PACKAGE: QFN32 5x5

Test	Specification	Condition	Interval	Results
PC	JESD22 A113 J-STD-020	MSL= 1 @ 260°C		0 / all
HAST	JESD22 A110	130°C/85% RH, bias, 96hrs	96 hrs	0 / 250
UHAST	JESD22 A118	130°C/85% RH, 96hrs	96 hrs	0 / 239
TC	JESD22 A104	-65°C to+150°C; for 500cyc	500 cyc	0 / 240
PTC	JESD22 A105	-40°C to+125°C; for 1000cyc	1000 cyc	0 / 45
HTSL	JESD22 A103	Ta=175°C for 500 hrs.	500 hrs	0 / 80
HTOL	JESD22 A108	Tj=150°C for 1008hrs.	1008 hrs	0 / 239
ELFR	AEC-Q100-008	Ta= 125°C for 48hrs	48 hrs	0 / 2400
WBS	AEC-Q100-001	Cpk >1.67		0 / all
WBP	Mil-Std-883 Method 2011	3.0gr. Condition C. 0 fails or Cpk>1.67.		0 / all
SD	JESD22 B102	8hr steam age, >95% coverage		0 / 45
PD	JESD22 B100/8	Cpk>1.67		0 / 90

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NOTE: AEC-1pager is attached.

To view attachments:

- 1. Download pdf copy of the PCN to your computer
- 2. Open the downloaded pdf copy of the PCN
- 3. Click on the paper clip icon available on the menu provided in the left/bottom portion of the screen to reveal the Attachment field
- 4. Then click on the attached file

Electrical Characteristics Summary:

Electrical characteristics are not impacted.

List of Affected Parts:

Note: Only the standard (off the shelf) part numbers are listed in the parts list. Any custom parts affected by this PCN are shown in the customer specific PCN addendum in the PCN email notification, or on the **PCN Customized Portal**.

Current Part Number	New Part Number	Qualification Vehicle
NCV97310MW33R2G	NCV97310MW33AR2G	NCV97311MW50AR2G
NCV97311MW33R2G	NCV97311MW33AR2G	NCV97311MW50AR2G
NCV97311MW50R2G	NCV97311MW50AR2G	NCV97311MW50AR2G

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